

**Notice of References Cited**

Application/Control No.

09/497,051

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

Timothy J Henn

Art Unit

2612

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,542,409	09-1985	Ochi, Shigeharu	348/281
	B	US-5,576,763	11-1996	Ackland et al.	348/308
	C	US-6,249,643	06-2001	Mimura, Toshihiko	386/107
	D	US-5,581,357	12-1996	Sasaki et al.	348/235
	E	US-5,446,493	08-1995	Endo et al.	348/320
	F	US-4,471,387	09-1984	Nadler, Morton	358/497
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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